

Search Notes

Application/Control No.

10/757,426

Examiner

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Applicant(s)/Patent under
Reexamination

HORIKAWA, TAKASHI

Art Unit

2123

SEARCHED

Class	Subclass	Date	Examiner
703	22	9/13/2006	<i>DMC</i>
717	124	9/13/2006	<i>DMC</i>
717	134	9/13/2006	<i>DMC</i>
717	135	9/13/2006	<i>DMC</i>
702	182	9/13/2006	<i>DMC</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT) see search notes for search terms	9/13/2006	<i>DMC</i>
IEEE (see search notes for search terms)	9/15/2006	<i>DMC</i>
GOOGLE (see search notes for search terms)	9/15/2006	<i>DMC</i>
EAST (US-PGPUBS; USPAT; USOCR; JPO; EPO; DERWENT; IBM_TDB) see search notes for search terms	9/18/2006	<i>DMC</i>